

Application/Control No 10/586,428	. Applicant(s)/Patent under Reexamination TEWES ET AL.
Examiner	Art Unit
John Kreck	3672

		PIONAL	ISSUE	<u> </u>	.70	<u> </u>			OL 400IE: 0.4	TION			
		RIGINAL		INTERNATIONAL CLASSIFICATION									
	CLASS	SOBC	LASS			CL	AIMED			NON-CLAIMED			
299 10			02 E		21	С	35	/197			1		
	CROSS	REFERENCES						,			,		
CLASS	SUBCLAS	S (ONE SUBCLASS PI	ER BLOCK)					1			1		
299	81.2							1			1		
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(Assi	/Joh	/John Kreck/ 5/19/09					Total Claims Allowed: 15						
,	struments Ex		(Primary Examiner) (Date)						O.G Print F				

Claims renumbered in the same order as presented by applicant								□СРА			☐ T.D.			☐ R.1.47					
Final	Original		Final	Original		Final	Original		Final	Original		Final	Original		Final	Original		Final	Original
	1			31			61	ĺ		91			121			151			181
	2			32			62			92			122			152			182
	3			33			63			93			123			153			183
	4			34			64			94			124			154			184
	5]		35			65]		95			125			155			185
	6			36			66]		96			126			156			186
	7			37			67]		97			127			157			187
	8			38			68			98			128			158			188
	9]		39			69]		99			129			159			189
	10]		40			70]		100			130			160			190
	11]		41			71]		101			131			161			191
	12			42			72]		102			132			162			192
	13]		43			73]		103			133			163			193
	14]		44			74]		104			134			164			194
	15]		45			75]		105			135			165			195
	16]		46			76]		106			136			166			196
	17			47			77]		107			137			167			197
	18]		48			78]		108			138			168			198
	19]		49			79]		109			139			169			199
	20]		50			80]		110			140			170			200
	21			51			81]		111			141			171			201
	22]		52			82]		112			142			172			202
	23			53			83			113			143			173			203
	24]		54			84]		114			144			174			204
	25			55			85]		115			145			175			205
	26			56			86			116			146			176			206
	27			57			87			117			147			177			207
	28]		58			88]		118			148			178			208
	29]		59			89]		119			149			179			209
	30			60			90			120			150			180			210